TOSHIBA Diode Silicon Epitaxial Planar Type

# 1SS360F

### Ultra High Speed Switching Applications

Unit in mm

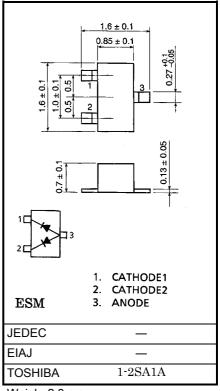
Small package : 1608 Flat lead Excellent in forward current and forward voltage characteristics  $V_{F(3)} = 0.92V \text{ (typ.)}$ Fast reverse recovery time:  $t_{rr} = 1.6ns$  (typ.)

Small total capacitance :  $C_T = 2.2pF$  (typ.)

#### Maximum Ratings (Ta = 25°C)

| Characteristic                 | Symbol           | Rating          | Unit |  |
|--------------------------------|------------------|-----------------|------|--|
| Maximum (peak) reverse voltage | $V_{RM}$         | 85              | V    |  |
| Reverse voltage                | $V_{R}$          | 80              | V    |  |
| Maximum (peak) forward current | I <sub>FM</sub>  | 300 (*)         | mA   |  |
| Average forward current        | IO               | 100 (*)         | mA   |  |
| Surge current (10ms)           | I <sub>FSM</sub> | 2 (*)           | Α    |  |
| Power dissipation              | Р                | 100             | mW   |  |
| Junction temperature           | Tj               | 125             | °C   |  |
| Storage temperature range      | T <sub>stg</sub> | <b>-</b> 55~125 | °C   |  |

Unit rating. Total rating = unit rating  $\times$  1.5



Weigh: 2.3 mg

## **Electrical Characteristics (Ta = 25°C)**

| Characteristic        | Symbol             | Test<br>Circuit | Test Condition                           | Min | Тур. | Max  | Unit |
|-----------------------|--------------------|-----------------|--|-----|------|------|------|
| Forward voltage       | V <sub>F (1)</sub> | _               | I <sub>F</sub> = 1mA                     | -   | 0.61 | -    |      |
|                       | V <sub>F (2)</sub> | _               | I <sub>F</sub> = 10mA                    | _   | 0.74 | _    | V    |
|                       | V <sub>F (3)</sub> | _               | I <sub>F</sub> = 100mA                   | _   | 0.92 | 1.20 |      |
| Reverse current       | I <sub>R (1)</sub> | _               | V <sub>R</sub> = 30V                     | _   | _    | 0.1  | μА   |
|                       | I <sub>R (2)</sub> | _               | V <sub>R</sub> = 80V                     | _   | _    | 0.5  |      |
| Total capacitance     | C <sub>T</sub>     | _               | V <sub>R</sub> = 0, f = 1MH <sub>z</sub> | _   | 2.2  | 4.0  | pF   |
| Reverse recovery time | t <sub>rr</sub>    | _               | $I_F = 10\text{mA}$ (Fig.1)              | _   | 1.6  | 4.0  | ns   |

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Fig.1 Reverse Recovery Time (trr) Test Circuit

## Marking

